Contribution submission to the conference Regensburg 2016

An Electrochemical, resonant Photoemission and Ambient Pressure-X-ray Photoelectron Spectroscopic Investigation of Si/TiO$_2$/Ni/Electrolyte Interfaces — Matthias H. Richter$^{1,2,7}$, Michael F. Lichterman$^{1,2}$, Shu Hu$^{1,2}$, Ethan J. Crumlin$^3$, Stephanus Axnanda$^3$, Marco Favaro$^{3,4}$, Walter Drisdell$^{3,4}$, Zahid Hussain$^3$, Bruce S. Brunschwig$^1$, Zhi Liu$^{3,5,6}$, Nathan S. Lewis$^{1,2}$, and Hans-Joachim Lewerenz$^{1,2}$ — 1Caltech, Pasadena, USA. — 2Joint Center for Artificial Photosynthesis, Pasadena, USA. — 3Lawrence Berkeley National Laboratory, Berkeley, USA. — 4Joint Center for Artificial Photosynthesis, Berkeley, USA. — 5Chinese Academy of Sciences, China. — 6ShanghaiTech University, China. — 7BTU C-S, Cottbus, Germany.


Part: O
Type: Vortrag;Talk
Topic: Solid-liquid interfaces: Structure, Spectroscopy
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